

# Search Notes



Application/Control No.

10/792,262

Examiner

Jeffrey S. Zweizig

Applicant(s)/Patent under Reexamination

TSCHANZ ET AL.

Art Unit

2816

## SEARCHED

Class	Subclass	Date	Examiner
327	512	2/16/2005	JZ
	513		
	530		
	534		
	535		
	537		
	540		
	543		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
327	513	2/23/2005	JZ
	534		

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

		DATE	EXMR
EAST		2/16/2005	JZ
L #	Hits	Search Text	
L2	489961	substrate	
L3	974105	body	
L4	3277	back adj gate	
L5	649	backgate	
L6	133522 8	2 or 3 or 4 or 5	
L7	136270	6 and bias	
L8	146073 9	off or leak or leakage	
L9	41941	8 adj current	
L10	8975	7 and 9	
L11	124747 9	temperature	
L12	5081	10 and 11	